

Based on Form PTO-1449  
(3/90)

ATTY. DOCKET NO.  
450101-02664

SERIAL NO.  
09/830,532

LIST OF REFERENCES CITED BY APPLICANT  
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APPLICANT  
Naoto IWAHASHI

FILING DATE  
June 25, 2001

GROUP  
2652

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
	AL						
	AM						
	AN						
	AO						
	AP						

OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)

B	AQ		PATENT ABSTRACTS OF JAPAN vol. 018, no. 690 (P-1851), 26 December 1994 (1994-12-26) & JP 06 274546 A (A T R JIDO HONYAKU DENWA KENKYUSHO:KK), 30 September 1994 (1994-09-30)
B	AR		PATENT ABSTRACTS OF JAPAN vol. 016, no. 100 (P-1323), 11 March 1992 (1992-03-11) & JP 03 276367 A (A T R JIDO HONYAKU DENWA KENKYUSHO:KK), 6 December 1991 (1991-12-06)

EXAMINER

DATE CONSIDERED

2/14/05

\* EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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	AA						

  

FOREIGN PATENT DOCUMENTS								
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
TS	AB	9-134360	05/20/97	Japan				
TS	AC	6-274548	09/30/94	Japan				
TS	AD	6-290210	10/18/94	Japan				
TS	AE	11-259482	09/24/99	Japan				
	AF							
	AG							
	AH							
	AI							
	AJ							
	AK							
	AL							
	AM							

  

OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)			
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TB	AA	4 916 614	04/10/90	Kaji et al.			
TB	AB	5 652 898	07/29/97	Kaji			
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
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